

# **Numerical and Experimental Investigation of Internal Short Circuits in a Li-ion Cell**

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**Energy Storage Task Lead: Ahmad Pesaran**

## **Contributors:**

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**Eric Darcy**

***National Renewable Energy Laboratory (Jan-Sep, 2010)***

***NASA-JSC***

## Timeline

- Project Start: 2009
- Project End : 2014
- Ongoing

## Budget

- FY10: \$500K
- FY11: Anticipated \$500K

## Barriers

- Li-ion abuse tolerance and reliability
- Li-ion performance

## Partners

- NASA-JSC
- Dow Kokam
- Battery Safety Consulting Inc.
- Battery Design LLC
- Sandia National Laboratories (SNL)
- U.S. Navy

Funded by Dave Howell, Energy Storage R&D  
Vehicle Technology Program, U.S. Department of Energy

## *Internal **Short Circuit (ISC)**, a Major Concern*

- Because of its high specific energy and power density, the Li-ion battery (LIB) is a promising candidate to date for electric energy storage in electric drive vehicles (EDVs)
- Safety concerns regarding **violent failure** of the LIB system are a major obstacle to overcome for fast market acceptance of EDV technologies
- Thermal instability and flammability of the LIB components make them prone to catastrophic thermal runaway under some rare **ISC** conditions
- Many safety incidents that take place in the field are due to an ISC that is **not detectable or predictable** at the point of manufacture

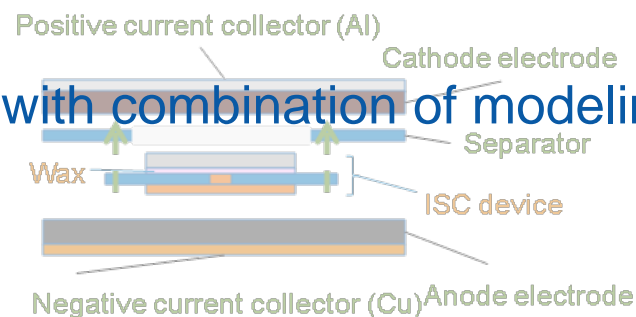
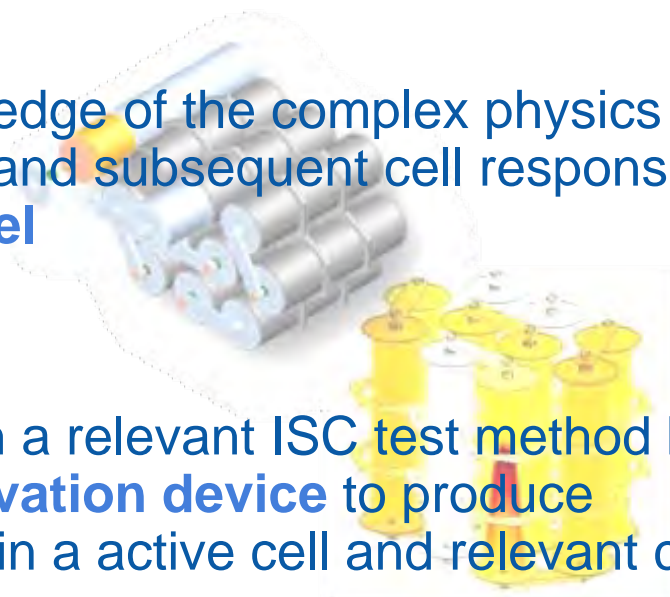
## ***Barriers for Addressing Failures Due to ISC***

- **Evolving during Life:** Latent defect gradually evolves to create an ISC while the battery is in use; inadequate design and/or off-limit operation causes Li plating, stressing separator
- **Difficulty of Early Detection:** Electrical and thermal signals of early stage ISCs are not easily detected in large-capacity LIB systems
- **Complex Physics with Numerous Sensitive Factors:** Behavior of a LIB with an ISC depends on various factors, including nature of the short; cell characteristics such as capacity, chemistry, electrical and configuration; and attributes of the pack where the cell is integrated
- **Poor Reproducibility:** To date, no reliable and practical method exists to create an on-demand ISC in Li-ion cells that produces a response that is relevant to the ones produced by field failures

# Objectives

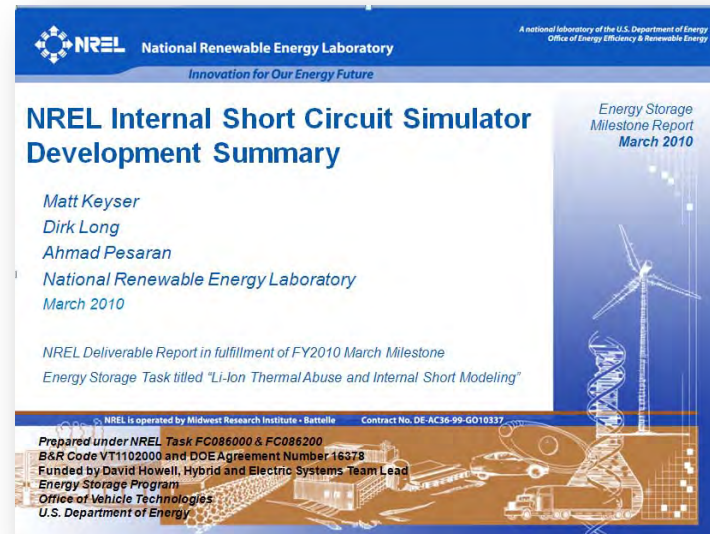
Relevance

1. **Model Investigation:** Enhance knowledge of the complex physics of evolution and development of an ISC and subsequent cell responses using NREL's **multiphysics ISC model**
2. **Test Method Development:** Establish a relevant ISC test method by developing an **on-demand short activation device** to produce representative and reproducible ISCs in a active cell and relevant cell responses
3. **Model+Test:** Perform a synergistic study with combination of modeling and experimental approaches



### ***FY10 Milestone Report***

- Matthew Keyser, Dirk Long, Ahmad Pesaran, “NREL Internal Short Circuit Simulator Development Summary”



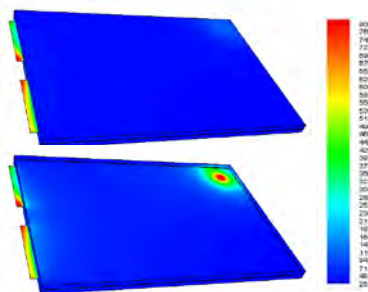
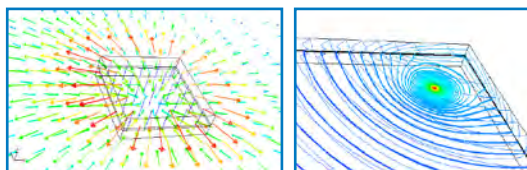
### ***FY11 Milestone Report – Due in September 2011***

- “Li-Ion Abuse Response Modeling and Internal Short Circuit Simulation”

## Focus of Modeling Study

Lead Investigator: Gi-Heon Kim

- Multiphysics ISC modeling
- Understanding cell behaviors



Model Validation  
Experiment Design

- Identify Critical Parameters
- Provide Complete Data Set for Non-Measurable Quantities

- Confirm Model Assumptions
- Provide Model Input

## Focus of Testing Study

Lead Investigator: Matthew Keyser

- Develop relevant ISC in active cell
- Provide consistent and reproducible results



Photo Credits:  
NREL – Dirk Long

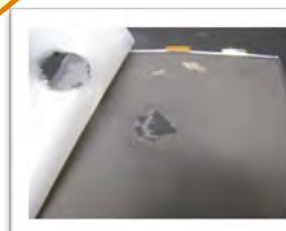
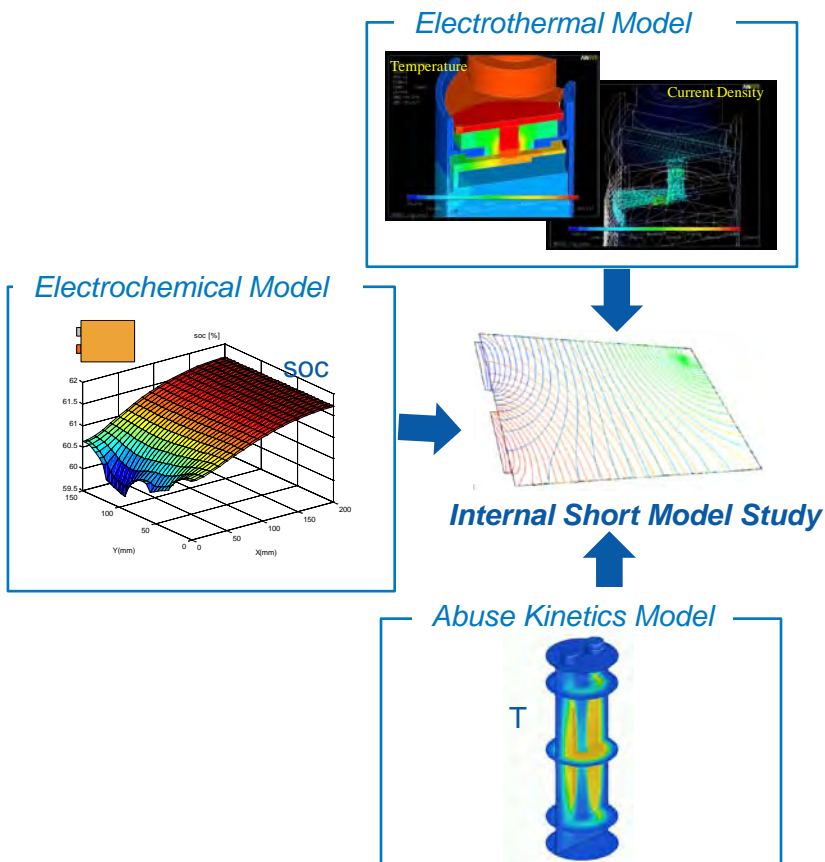


Photo Credits: Dow Kokam – Ben McCarthy

## ❖ Internal Short Circuit Modeling

- Perform multiphysics ISC model study using NREL's [electrochemical](#), [electrothermal](#), and [abuse reaction kinetics](#) models
- Predict cell responses and onset of thermal runaway corresponding to the nature of the short and cell characteristics



### Cases for Short Path

- ISC between metal (Al & Cu) current collector foils



- ISC between electrode (cathode & anode) layers



- ISC between Al to anode – short bypassing cathode

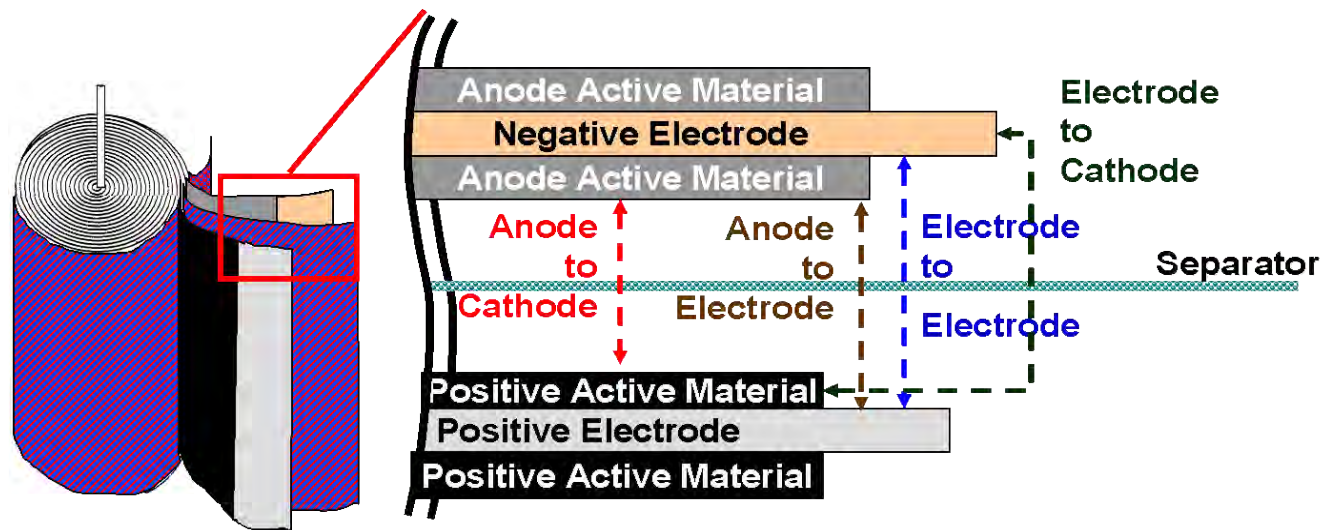


- Impact of cell size
- Impact of ISC location



## ❖ Internal Short Circuit Instigator Device Development

- Small, low-profile and implantable into Li-ion cells, preferably during assembly
- Consistent and repeatable activation of internal short
- Electrolyte-compatible phase change material (PCM) for key component
- Triggered by heating the cell above PCM melting temperature



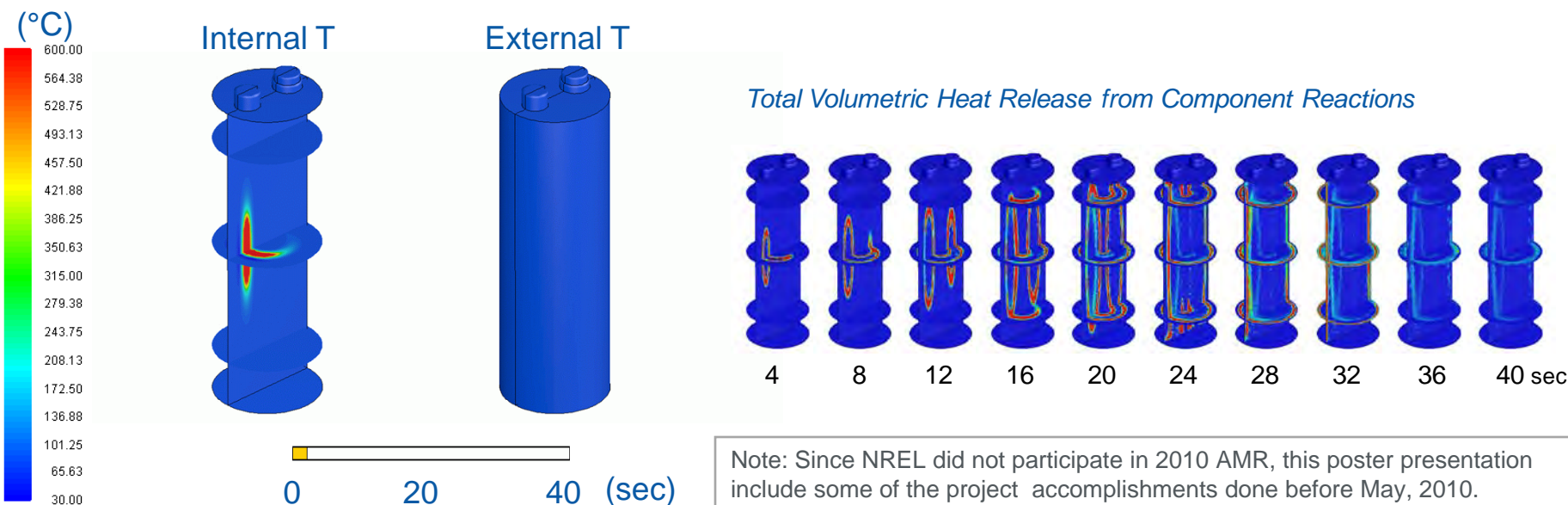
Spiral wound battery shown – can also be applied to prismatic batteries.

Spiral wound battery shown – can also be applied to prismatic batteries

# Previous Accomplishments

## Technical Accomplishments

- Three-dimensional LIB abuse kinetics model was developed in support of DOE's ATD program, and the development was continued in the DOE's ABR program
- Previous study
  - ✓ Focused on understanding the interaction between heat transfer and exothermic abuse reaction propagation for a particular cell/module design
  - ✓ Provided insight on how thermal characteristics and conditions can impact safety events of LIBs



## ISC Model Investigation

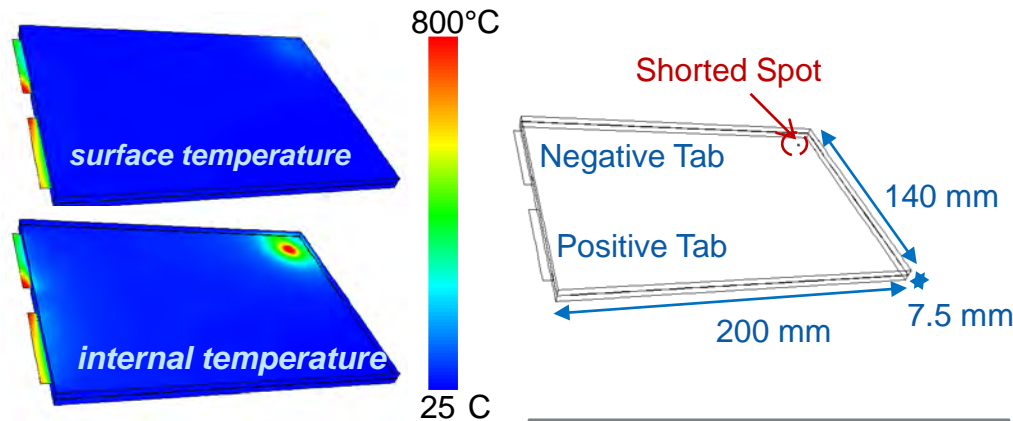
# Impact of Cell Capacity

## Initial cell heating pattern under ISC varies with cell capacity

- Shorted area: 1 mm x 1 mm
- Short between Al and Cu foils

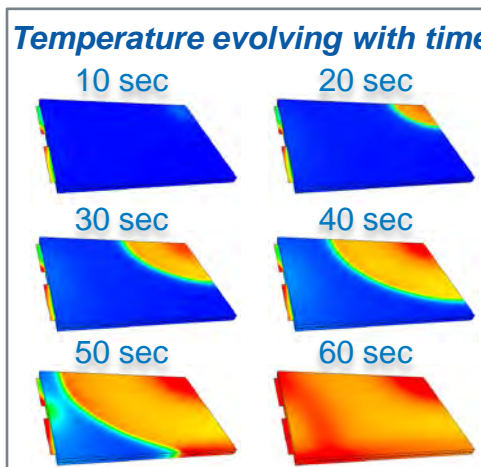
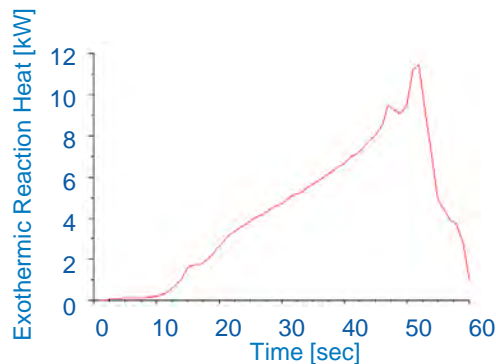
### 20 Ah cell

- $R_{\text{short}} \sim 10 \text{ m}\Omega$
- $I_{\text{short}} \sim 300 \text{ A}$  (15 C-rate)



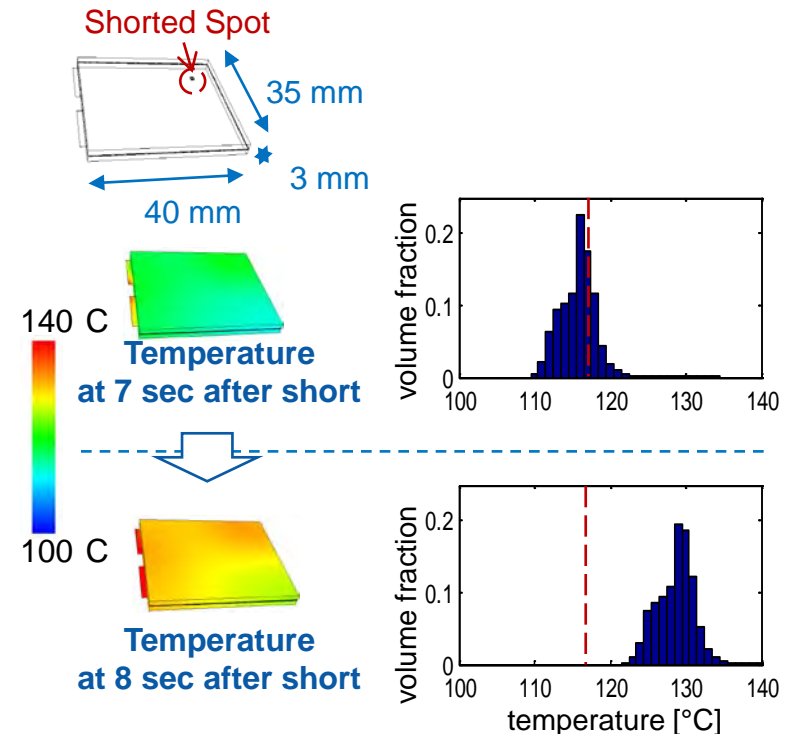
Temperature at 10 sec after short

Temperature evolving with time



### 0.4 Ah cell

- $R_{\text{short}} \sim 7 \text{ m}\Omega$
- $I_{\text{short}} \sim 34 \text{ A}$  (85 C-rate)



- A small-capacity cell is heated globally
- ISC heating in a large cell is likely local
- Thermally triggered “shut-down separator” may function effectively in a small cell

# Impact of Separator Integrity

## Technical Accomplishments

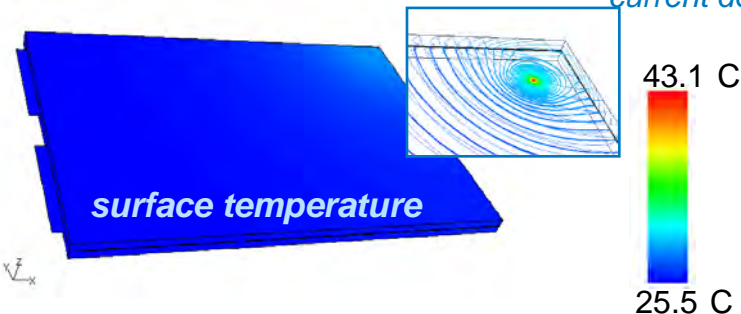
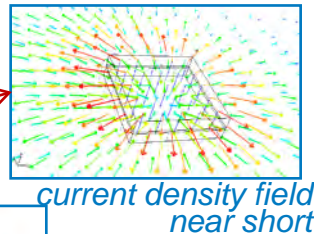
Maintaining integrity of separator seems critical to delay evolution of the short

- Short between anode to cathode
- 20 Ah capacity cell

Shorted area: 1 mm x 1 mm

- $R_{\text{short}} \sim 20 \Omega$
- $I_{\text{short}} \sim 0.16 \text{ A}$  ( $< 0.01 \text{ C-rate}$ )

1cm x 1cm Separator Hole



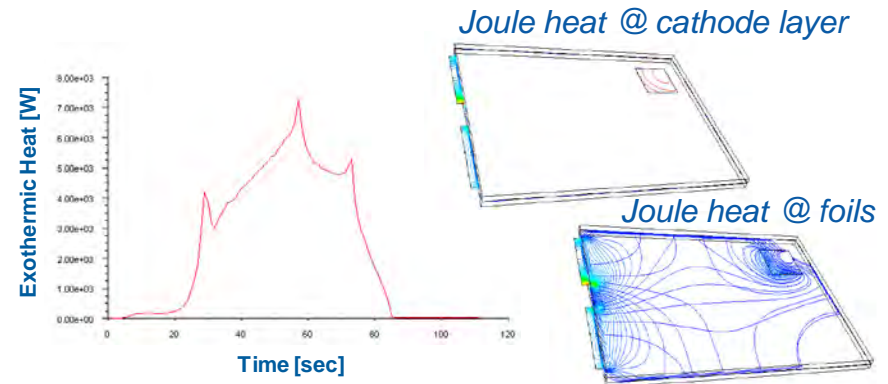
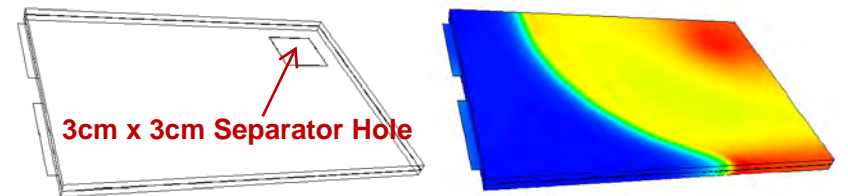
- Thermal signature of the short is hard to detect from the surface
- The short for simple separator puncture is not likely to lead to an immediate thermal runaway

separator hole propagation

Shorted area: 3 cm x 3 cm

- $R_{\text{short}} \sim 30 \text{ m}\Omega$
- $I_{\text{short}} \sim 100 \text{ A}$  (5 C)

Temperature at 1min after short



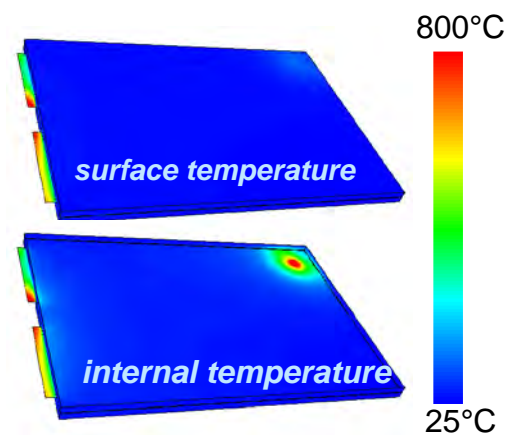
# Impact of Short Paths

## Electrical resistance of ISC varies with short path across electrodes

- 20 Ah capacity cell

### Short between Al & Cu foils

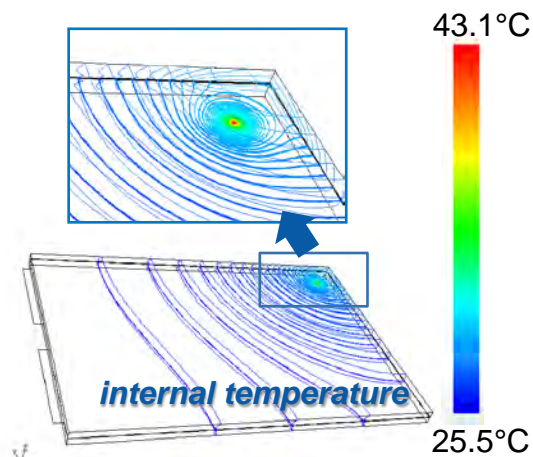
- $R_{\text{short}} \sim 10 \text{ m}\Omega$
- $I_{\text{short}} \sim 300 \text{ A}$  (15 C-rate)



Temperatures at 10 sec after short

### Short between anode and cathode

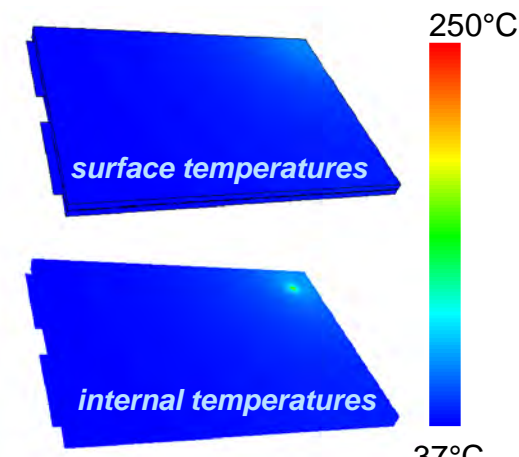
- $R_{\text{short}} \sim 20 \Omega$
- $I_{\text{short}} \sim 0.16 \text{ A}$  (<0.01 C-rate)



Temperatures at 20 min after short

### Short between anode and Al foil

- $R_{\text{short}} \sim 2 \Omega$
- $I_{\text{short}} \sim 1.8 \text{ A}$  (<0.1 C-rate)



Temperatures at 1 hr after short

- ISC bypassing cathode is likely to evolve into a hard short in relatively brief time



# Impact of Short Location

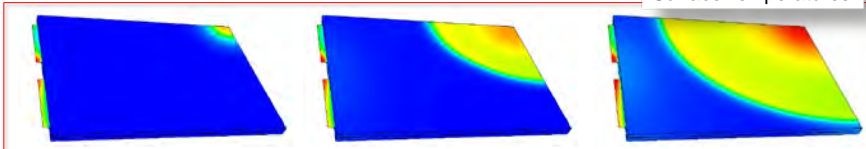
## Technical Accomplishments

Cell response varies with short location and cell electrical configuration

ISC Far from Tab

20-Ah capacity stacked cell

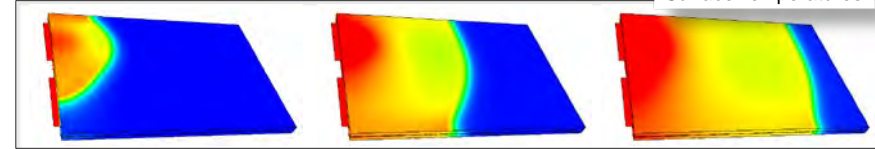
Surface Temperatures



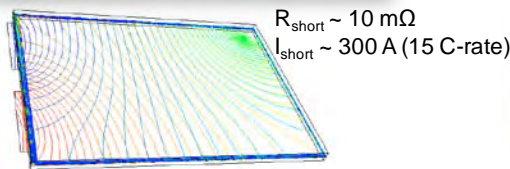
50°C 900°C

ISC Near Tab

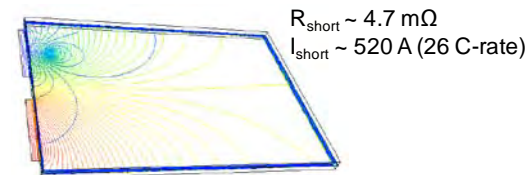
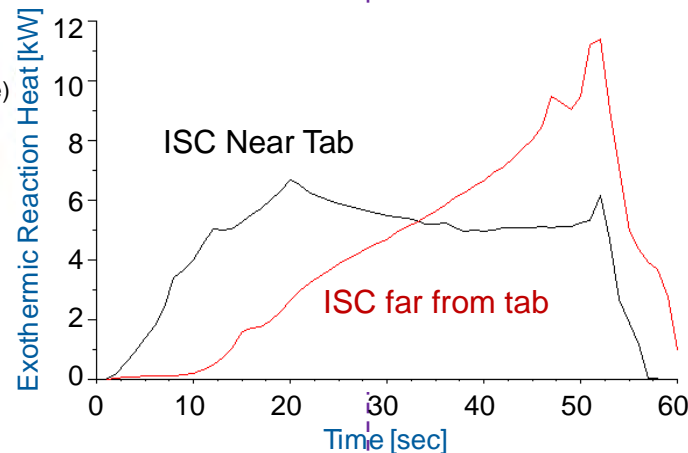
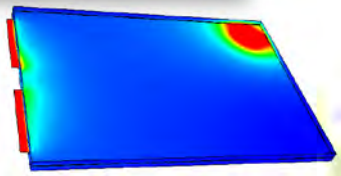
Surface Temperatures



Electric Potential at Shorting Layers



Internal Temperatures



- For low-resistance ISC, near-tab ISC results in a smaller resistance because of shorter short-current path through shorting layers
- Pattern of local heating for convergence of short-current varies with location of short and internal electrical configuration of a cell

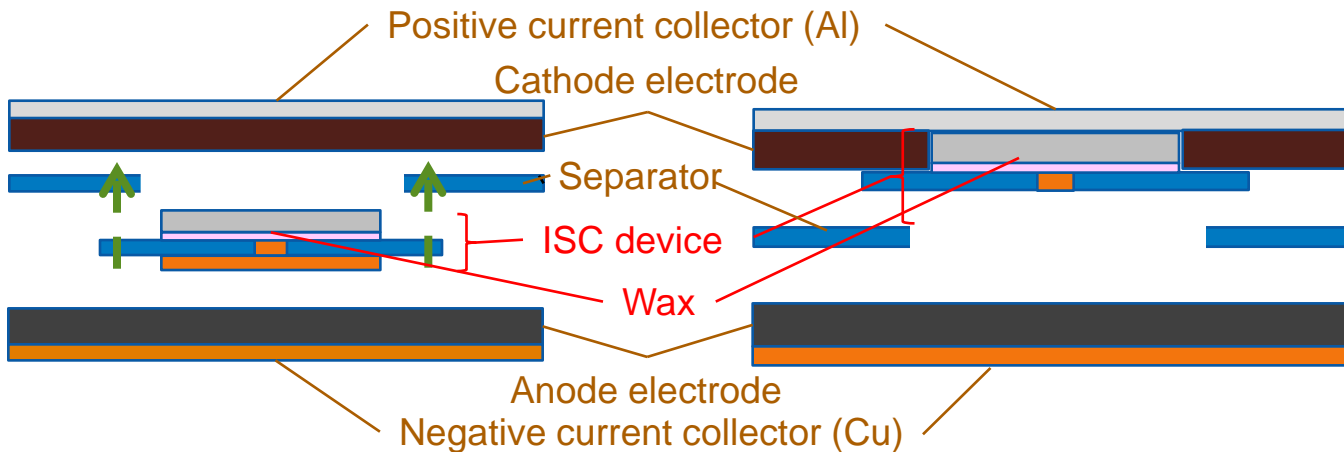
## ISC Test Method Development



NREL developed an on-demand activation device creating representative ISC

### ❖ NREL's ISC instigator design

#### • Anode to Cathode ISC



Activated short with PCM wicked by battery separator



Photo Credit: Dirk Long, NREL

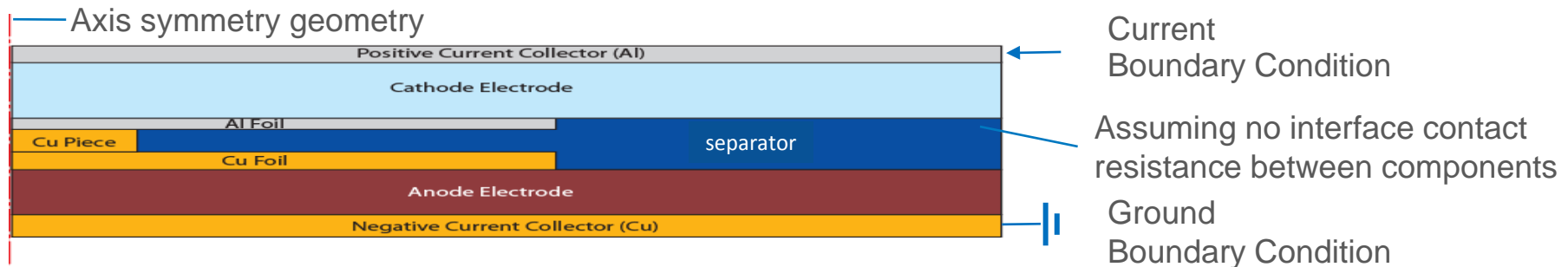
*This device is applied for patent*

- Triggered by heating the cell above PCM melting temperature (presently 40°C – 60°C)
- Initial device design focus is on anode-to-cathode active material short
- Improved device design focus is on anode-to-Al short

# Characterizing the ISC Device

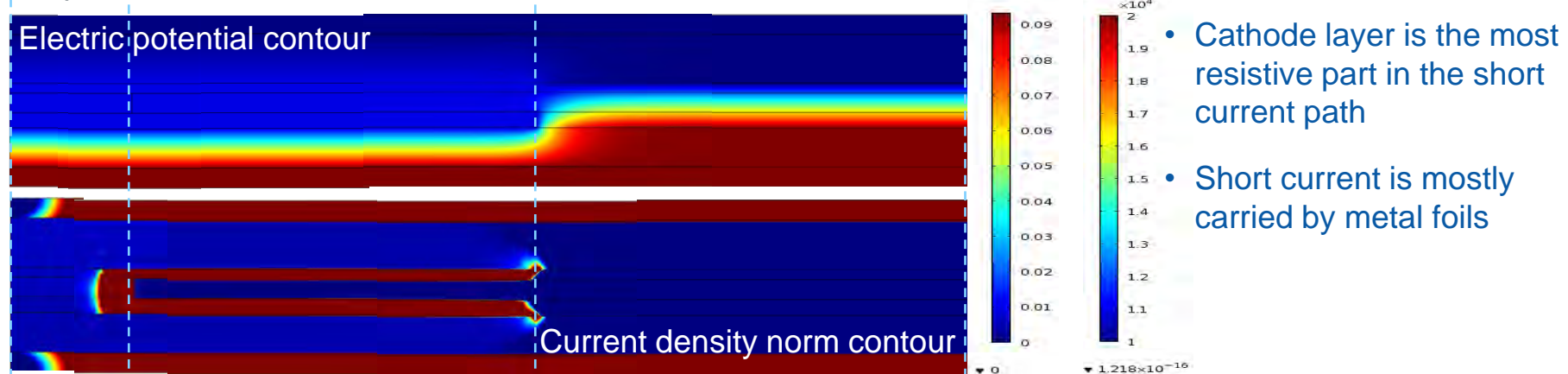
## Technical Accomplishments

Model helps to understand characteristics of ISC device and short triggered



Property	Al pad	Cu pad	Cu piece	Positive current collector	Negative current collector	Cathode electrode	Anode electrode	Separator
Electric conductivity [S/m]	$3.541 \times 10^7$	$5.8 \times 10^7$	$5.8 \times 10^7$	$3.541 \times 10^7$	$5.8 \times 10^7$	5	58	$1 \times 10^{-15}$

Graphic not drawn to scale

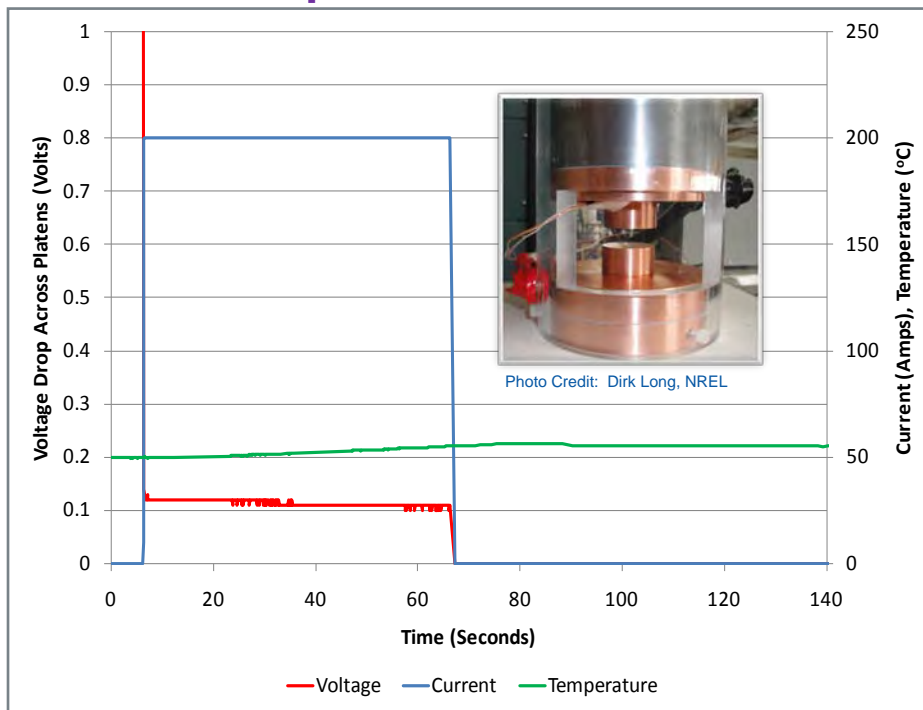


# ISC Device Function Test

## Technical Accomplishments

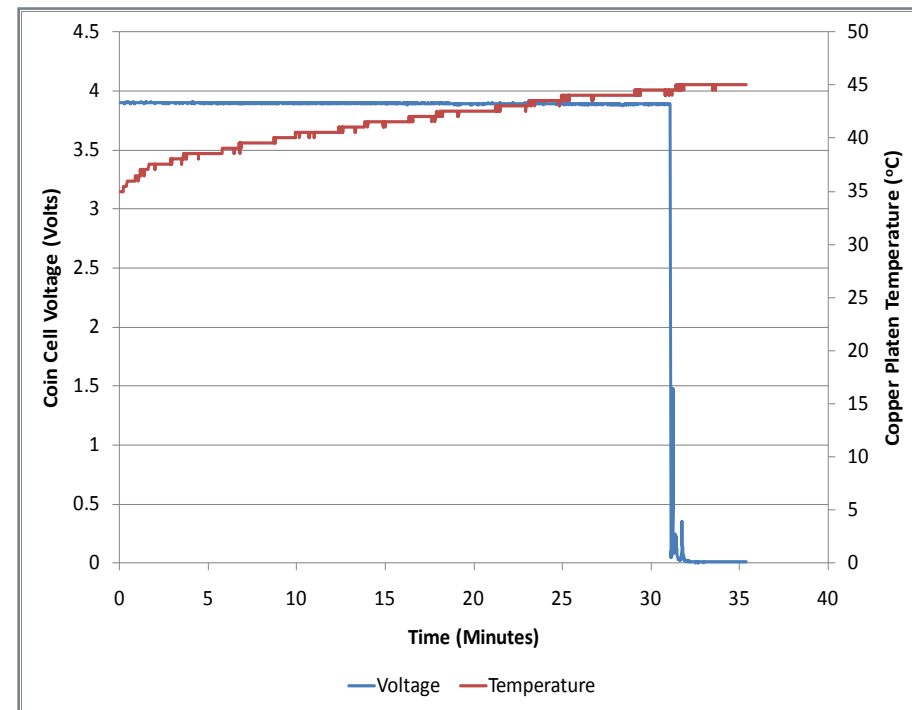
NREL ISC device consistently activated a short in laboratory testing

### • Impedance test



Consistent Short Impedance ~ 0.5 m $\Omega$

### • Coin cell test



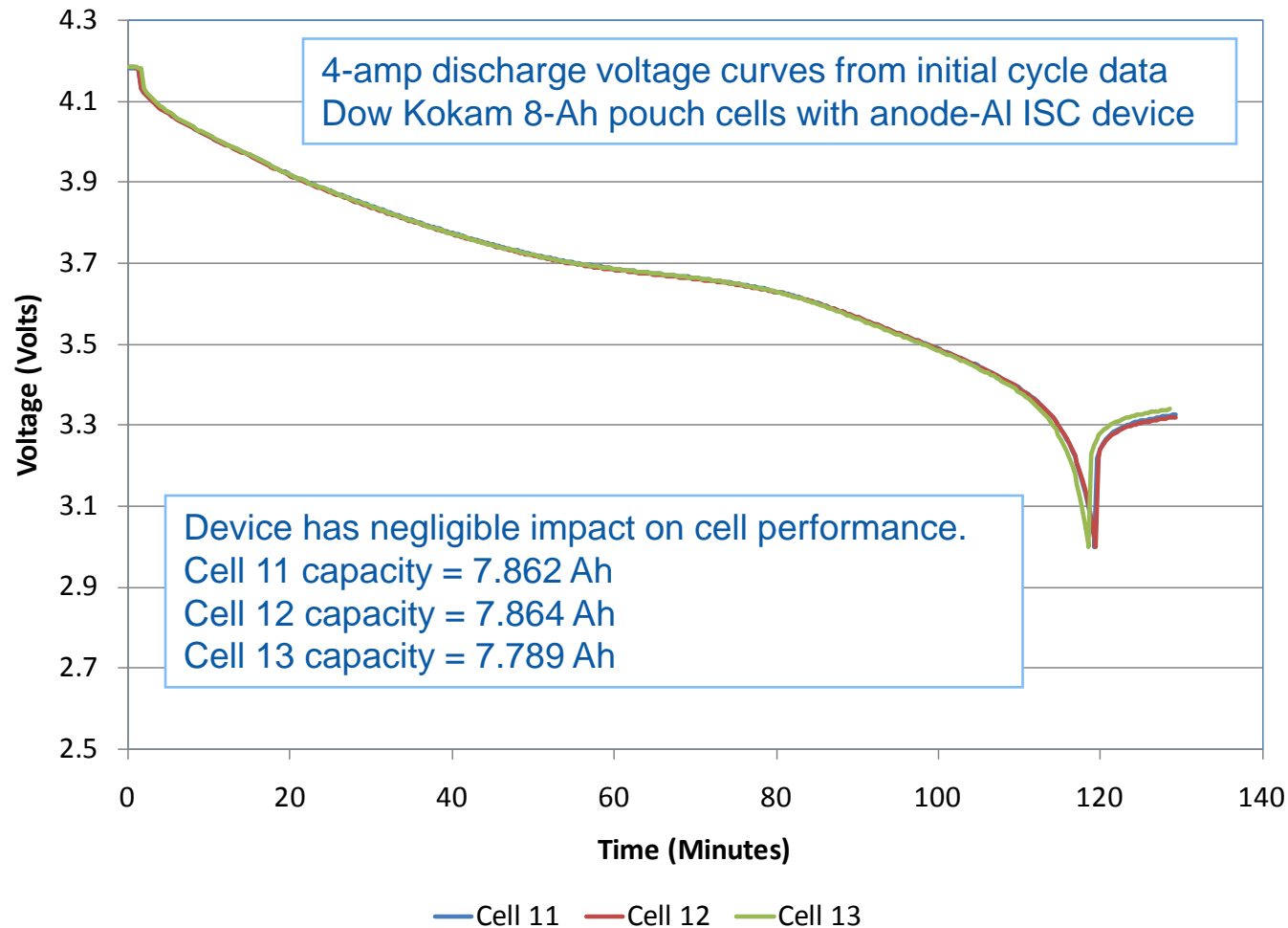
Reliable ISC Trigger in Coin Cells – 100% Success Rate

- In laboratory testing, the activated device can handle currents in excess of 200 A to simulate hard shorts (<5m $\Omega$ ).
- Phase change from non-conducting to conducting has been 100% successful during trigger tests.
- Separator is an excellent wick for melted PCM.
- Nine of nine coin cells shorted with new ISC device design, shown here using a 42°C – 44°C melting PCM.

# ISC Device Implantation in a Large Cell

## Technical Accomplishments

Implantation of NREL ISC device does not impact electrochemical performance of 8-Ah Dow Kokam cells



# Implanting Anode-to-Cathode ISC in 8-Ah cells

## Technical Accomplishments

ISC was consistently activated in 8-Ah stacked cells using NREL's ISC device

### Implantation of ISC Device for Anode to Cathode short

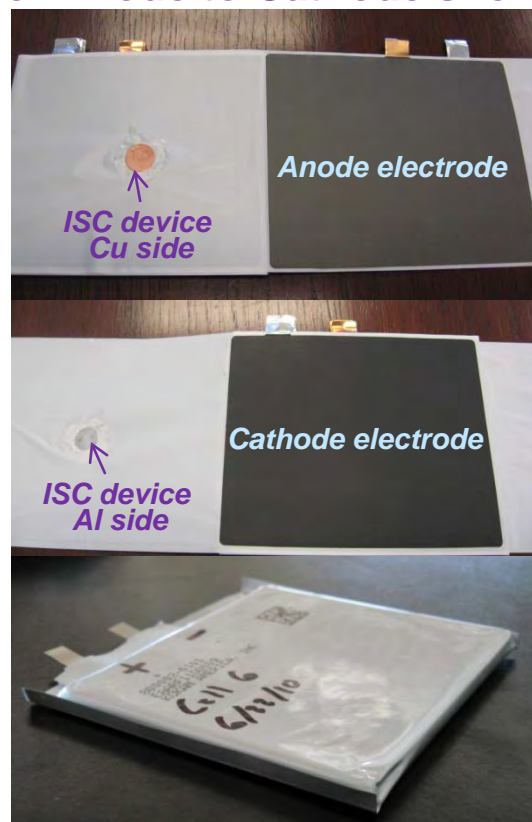
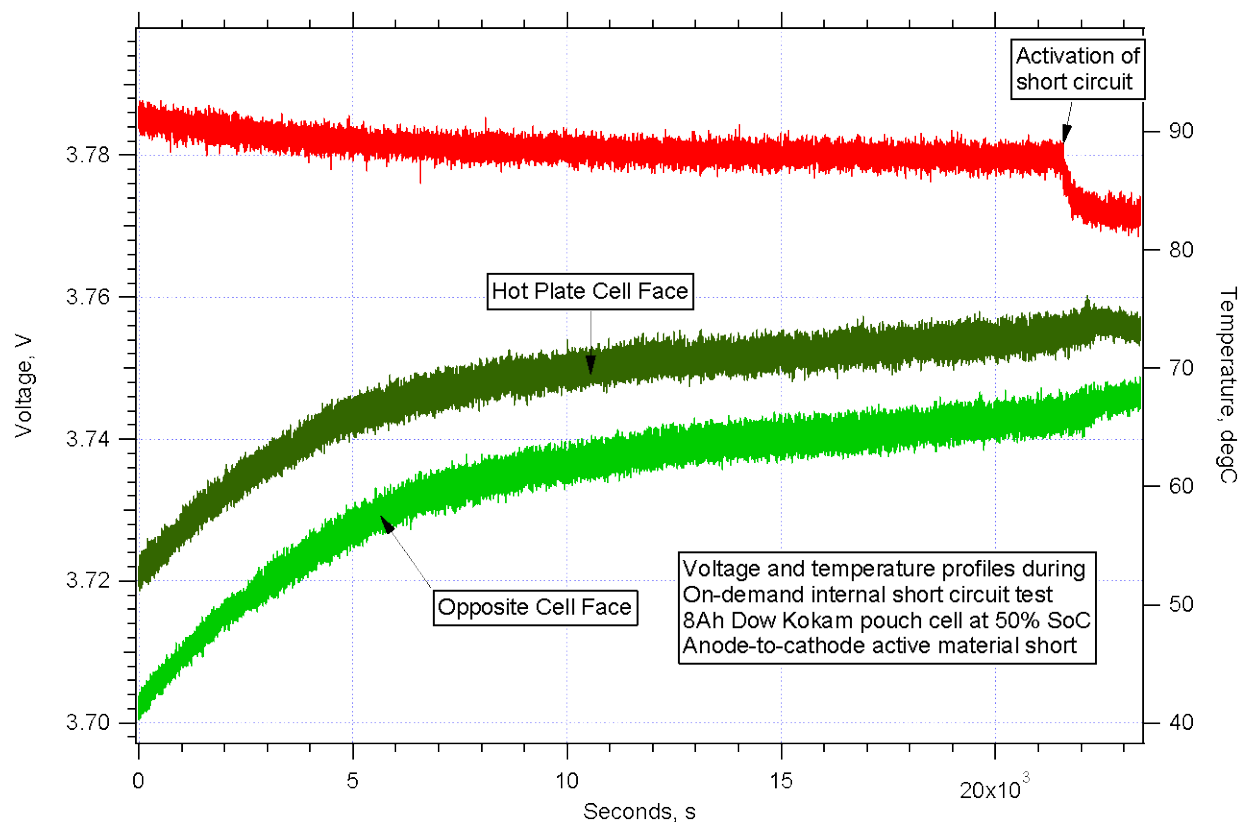


Photo Credits: Dow Kokam – Ben McCarthy

Shown here implanted inside a Dow Kokam 8-Ah pouch cell

### Voltage Response to ISC



- Thermal runaway was not observed due to high impedance of the ISC between anode-to-cathode electrode surfaces

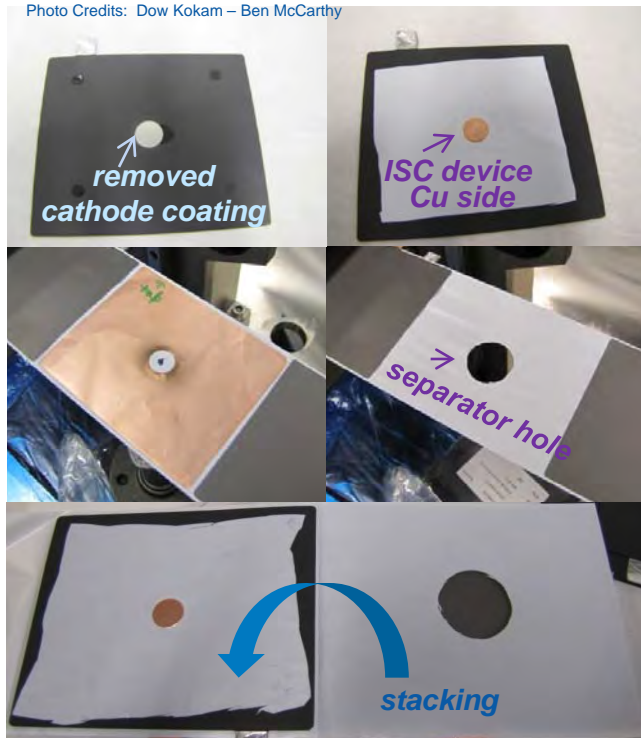
# Implanting Anode-to-Al ISC in 8-Ah cells

## Technical Accomplishments

Anode-to-Al ISC implanted yielded lower impedance shorts in a 8-Ah cell

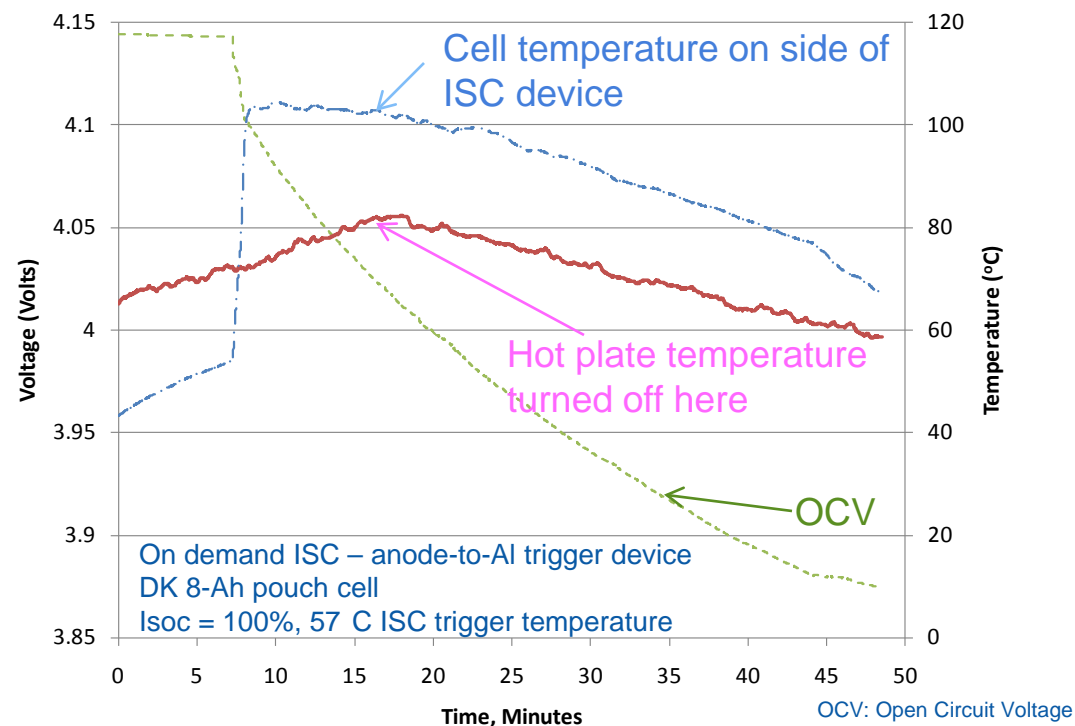
### Implantation of ISC Device for Anode-to-Aluminum short

Photo Credits: Dow Kokam – Ben McCarthy



Dow Kokam lightly glued the custom ISC device to the modified cathode, lined up the separator hole with a template to center the separator hole, and then allowed stacking to proceed.

### Voltage, Temperature Response to ISC



Detected a 55 C temperature rise in 80 seconds

- NREL's ISC device was easily implanted during the manufacturing process on DK's automated production line



# Destructive Physical Analysis of Triggered Cell

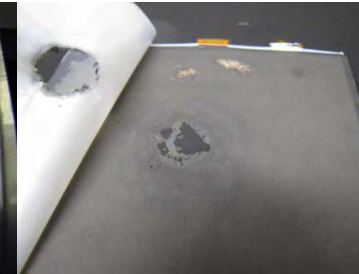
## Technical Accomplishments

Severe heat-affected zones were observed near the implanted short, subsequently creating separator holes in the adjacent layers

Photo Credit: Dow Kokam – Ben McCarthy



Inside pouch



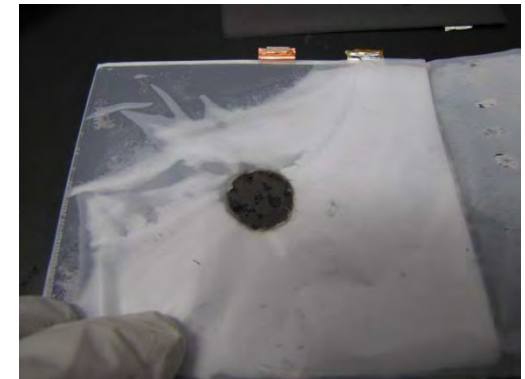
Anode electrode



Damaged separator

Unfolding the cell after the anode-to-Al short

- Severe heat-affected zones in eight electrode layers in vicinity of ISC device and on inside of pouch laminate side near short.
- Tabs stayed intact.
- Anode and cathode sandwiching the ISC were not yet separated to prevent damage.



Photos courtesy of Ben McCarthy, Dow Kokam

### Dow Kokam

- Dow Kokam assembled ISC-implanted cells and tested them to evaluate NREL's ISC instigator device

### NASA Johnson Space Center

- Eric Darcy of NASA-JSC, awarded by NASA's Innovation Ambassador Program, joined NREL's energy storage team (Jan ~ Sep 2010) and participated in the invention of NREL's ISC instigator device
- NASA-JSC also tested the ISC device at its facilities in Houston, Texas

### Battery Safety Consulting, Inc.

- Dr. Daniel Doughty of Battery Safety Consulting, Inc. was subcontracted to submit a recommendation of Li-ion "Safety Roadmap" to DOE
- This document analyzes battery safety and failure modes of state-of-the-art cells and batteries and makes recommendations on future investments that would support DOE's mission



### Battery Design LLC

- NREL researchers are collaborating with Robert Spotnitz of Battery Design LLC to expand NREL's exothermic kinetics (empirical) model inventory

### Sandia National Laboratories

- NREL researchers continue to discuss using SNL's test data for NREL's model development and validation with Christopher Orendorff of SNL

### U.S. Navy

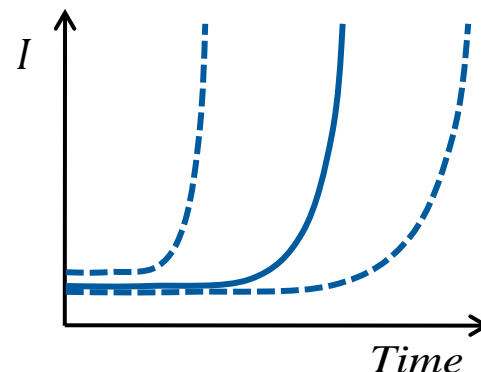
- NREL researchers continue to discuss using Naval Surface Warfare Center (NSWC) test data for NREL's model development and validation with Clint Winchester of NSWC's Carderock division

### ❖ NREL ISC Device

- Test cathode-to-Cu and Al-Cu collector shorts in stacked cells
- Implant and test ISC device in 18650 cylindrical cell designs (with NASA)
- Test the effectiveness of battery management systems in preventing collateral damage to cells neighboring the cell with an ISC
- Partner with cell manufacturers and auto industry to help them design safer LIB systems, which appears critical to realizing technologies for green mobility

### ❖ ISC Evolution Study

- Understand initial evolution of an ISC using a controllable test fixture
- Investigate factors and conditions affecting the time scale for ISC development
- Quantify the sensitivity of the factors

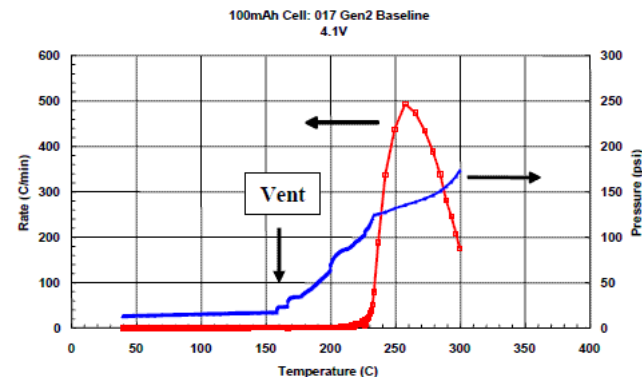


# Future Work

## Future Work / Deployment Strategy

### ❖ Pressure Model

- Predict pressure evolving inside a battery container during thermal runaway
- Understand cell venting mechanism
- Based on empirical correlations between temperature and volume of gas evolved from abuse reactions



ARC chamber pressure evolution  
C. Orendorff, SNL

### ❖ Modeling Overcharge Mechanism

- Cathode Instability: Changes in the composition and lattice structure of the cathode host matrix during overcharge will be simulated
- Electrolyte Decomposition: The electrolyte decomposes due to the high voltage. The reactions taking place during this process will be included in the safety model
- Lithium Deposition: Lithium deposition during overcharge is usually assumed to take place when the anode voltage goes below 0V vs. lithium, whereas in this work we will explore the factors leading to the drop in the anode voltage

# Summary – Model Investigation

## Summary

- *The multiphysics ISC model study was performed using NREL's electrochemical, electrothermal, and abuse reaction kinetics models*
- Initial cell heating pattern under ISC varies with cell capacity
- Maintaining integrity of separator seems critical to delay evolution of the short
- The short for simple separator puncture is not likely to lead to an immediate thermal runaway
- Electrical resistance of ISC varies with short path across electrodes
- ISC bypassing cathode is likely to evolve into a hard short in relatively short time
- Cell thermal runaway response varies with short location and cell electrical configuration
- For low-resistance ISC, near-tab ISC results in a smaller resistance in a stacked cell because of shorter short-current path through shorting layers
- Pattern of local heating for convergence of short current varies with the location of the short and the internal electrical configuration of the cell

# Summary – Test Method Development

## Summary

- ***NREL has developed a small, low profile device for simulating ISCs in active Li-Ion cells (applied for a patent)***
- The ISC device was proven to activate a short consistently and repeatedly in laboratory tests
- To date, anode-cathode and anode-Al short-circuit cases have been tested in Li-ion coin and stacked pouch cells
- Implantation of NREL ISC device does not impact electrochemical performance of 8-Ah Dow Kokam cells
- The ISC device has shown great potential to produce results relevant to field failures caused by internal cell defects
  - Evaluation of ISC response of a cell no longer has to rely on less-relevant crush tests
  - Results show promise to guide and focus cell production line defect and contamination mitigation measures
  - Comparison of the abuse tolerance of various cell designs will be possible

# Publications and Presentations

1. G.-H. Kim, L. Chaney, K. Smith, A. Pesaran, E. Darcy, "Thermal Analysis of the Vulnerability of the Spacesuit Battery Design to Short-Circuit Conditions," 2010 Space Power Workshop, Manhattan Beach, CA, April 22, 2010.
2. G.-H. Kim, K. Smith, K.-J. Lee, A. Pesaran, "Integrated Lithium-Ion Battery Model Encompassing Physics in Varied Length Scales," The 3rd International Conference on Advanced Lithium Batteries for Automobile Application, Seoul, Korea, September 8–10, 2010.
3. G.-H. Kim, K.-J. Lee, L. Chaney, K. Smith, E. Darcy, A. Pesaran, "Numerical Analysis on Multi-physics Behaviors of Lithium-ion Batteries for Internal and External Short," 218<sup>th</sup> ECS Meeting, Las Vegas, NV, October 10–15, 2010.
4. G.-H. Kim, K.-J. Lee, L. Chaney, K. Smith, E. Darcy, A. Pesaran, "Prediction of Multi-physics Behaviors of Large Lithium-ion Batteries at Internal and External Short Circuit," Battery Safety 2010 in conjunction with 6th Lithium Mobile Power, Boston, MA, November 3, 2010.
5. E. Darcy, M. Keyser, D. Long, Y.S. Jung, G.-H. Kim, A. Pesaran, B. McCarty, "On-Demand Internal Short Circuit Device," 2010 NASA Aerospace Battery Workshop, Huntsville, AL, November 17, 2010.
6. M. Keyser, D. Long, Y.S. Jung, A. Pesaran, E. Darcy, B. McCarthy, L. Patrick, C. Kruger, "Development of a Novel Test Method for On-Demand Internal Short Circuit in a Li-Ion Cell," Large Lithium Ion Battery Technology and Application Symposium in conjunction with Advanced Automotive Battery Conference 2011, Pasadena, CA, January, 24–28, 2010.
7. E. Darcy, M. Keyser, D. Long, Y.S. Jung, A. Pesaran, B. McCarthy, "On-Demand Internal Short Circuit Device," 83<sup>rd</sup> Li Battery Technical/Safety Group Meeting, Key West, FL, February 16–17, 2011.

# Technical Back-up Slides

# *Current abuse test methods may not be relevant to field failures*

## Penetration and Crush Tests Methods

- Army/Navy/FBI use nail/bullet penetration tests.<sup>1</sup>
- NASA uses a crush test with a rounded rod.<sup>2</sup>
- Underwriters Laboratory (UL) uses a blunt nail crush test.<sup>3</sup>
- Motorola/Oak Ridge National Laboratory use a pinch (crush) test on pouch cells.<sup>4</sup>

## Reliable, but not representative of field failures

1. Lyman, P., and Klimek, P., 69th Lithium Battery Technical/Safety Meeting, Myrtle Beach 2004.
2. Jeevarajan, J., 2008 NASA Aerospace Battery Workshop, Huntsville, AL.
3. Chapin, T., and Wu, A., 2009 NASA Aerospace Battery Workshop, Huntsville, AL.
4. Maleki, H., and Howard, J.N., *J. Power Sources*, 2008.



# *Current abuse test methods may not be relevant to field failures*

## Contamination Test Methods

- BAJ<sup>5</sup> and Celgard<sup>6</sup> retrofitted a Ni particle into the jellyroll of a cell and triggered the event using a crush test.
- Sandia National Laboratories has tried several methods<sup>7,8,9</sup>:
  - Building cells with Ni particle contamination and combined with sonication, thermal ramp, or overcharge to trigger the short
  - Implanting low-melting indium (In) alloy in the separator combined with heat trigger.
- TIAX retrofitted a metallic particle into the jellyroll of a cell and triggered the event by repeated charge/discharge cycling.<sup>10</sup>

**More relevant, but with reliability and reproducibility challenges**

5. Battery Association of Japan, Nov 11, 2008, presentation on web.
6. S. Santhanagopalan et al., *J. Power Sources*, 194 (2009) 550-557.
7. Orendorff, C., et al., ECS Meeting, May 2009.
8. Orendorff, C., and Roth, E.P., USABC TT Meeting, Feb 2009.
9. Orendorff, C., et al., ECS Meeting, Oct 2010.
10. Barnett, B., et al., 2010 Power Sources Conference.

# Laboratory Test Fixture

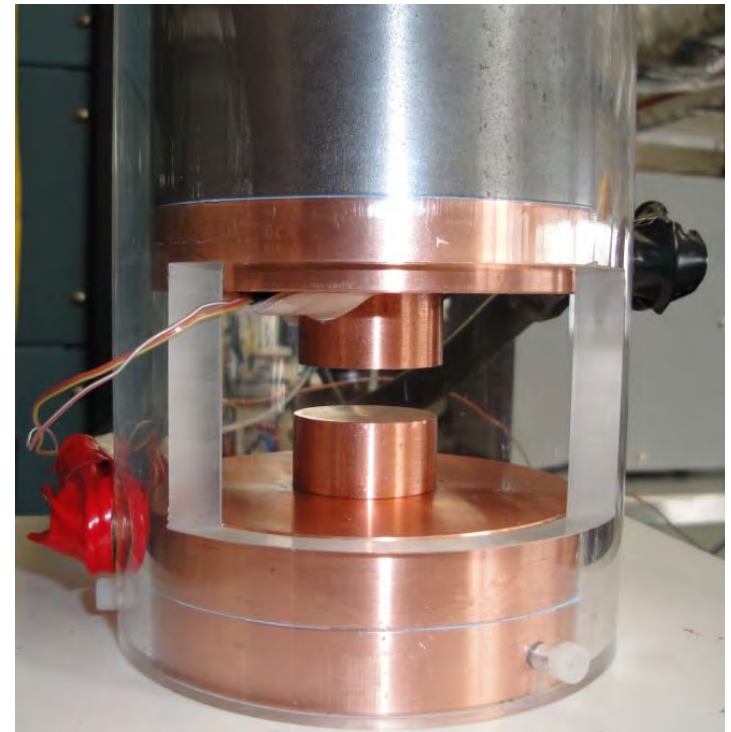
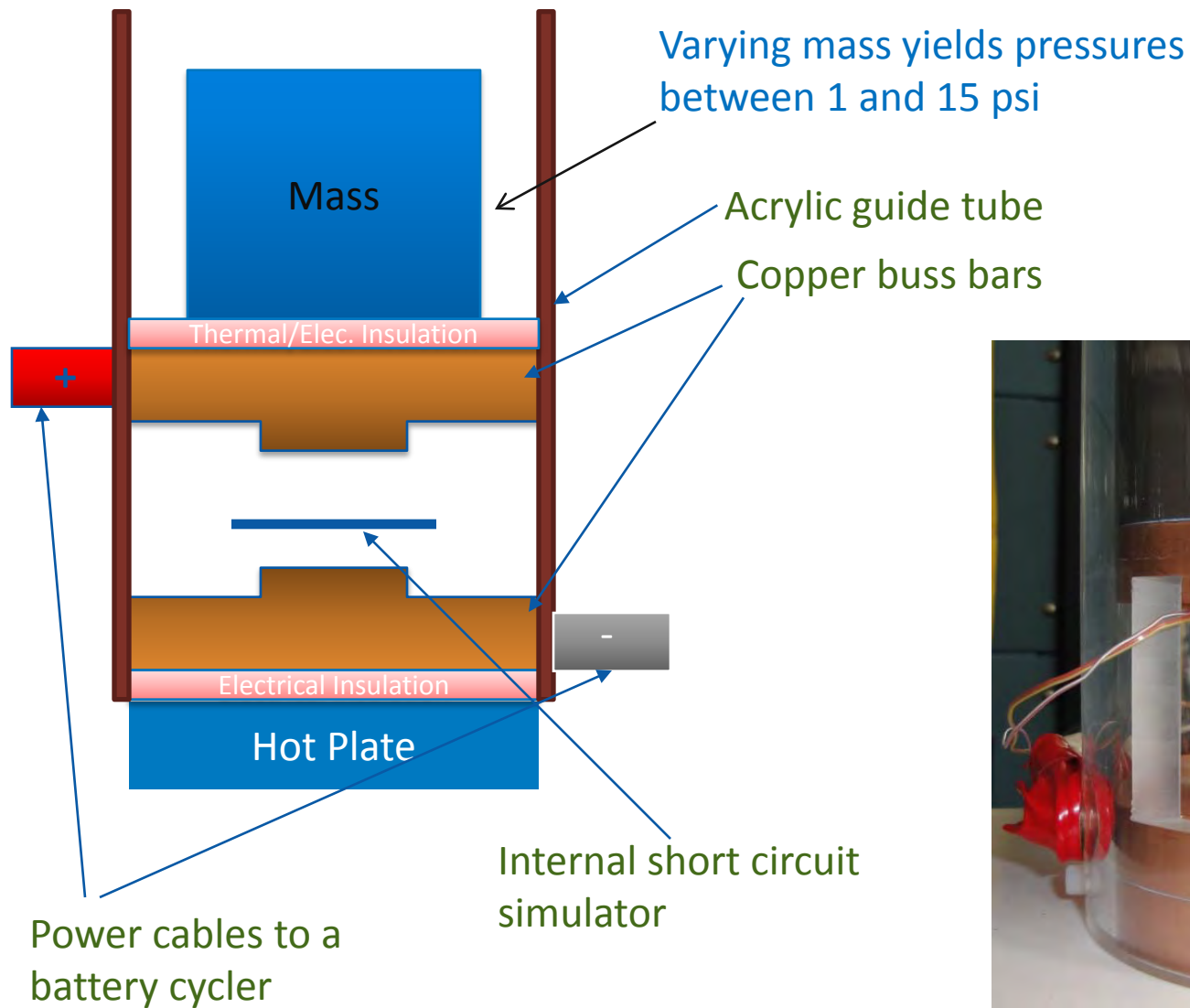
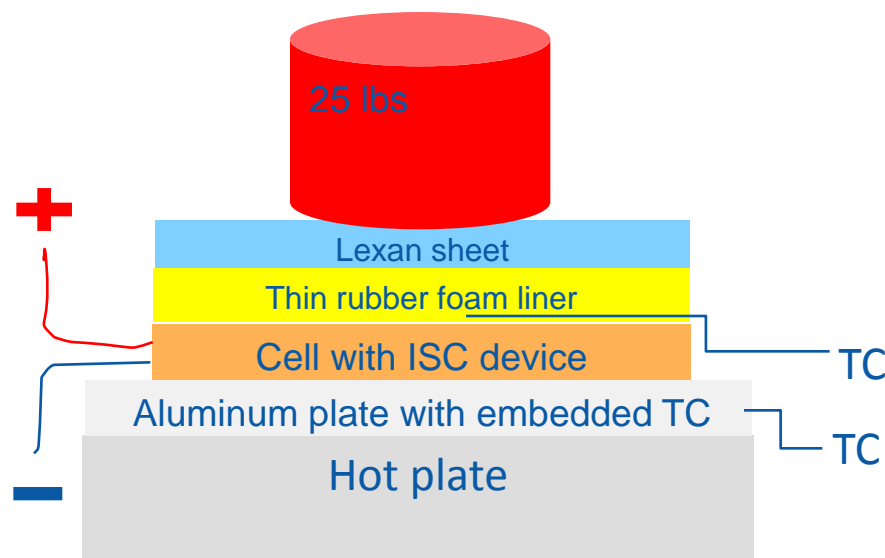


Photo Credit: Dirk Long, NREL

# Test Setup for Triggering ISC Implanted in a Cell

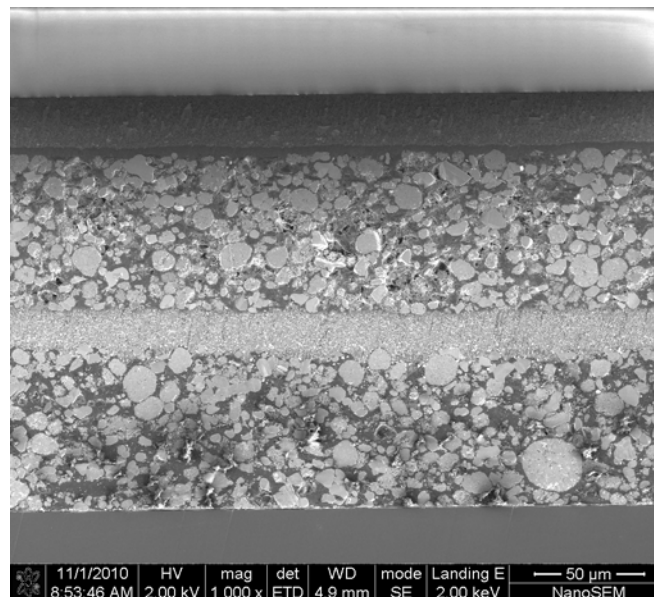
- Cell is charged to the appropriate state of charge.
- Hot plate provides the heating source.
- Cell is placed under compression ( $\sim 1.6$  psi).
- Al plate between hot plate and cell has an embedded thermocouple (TC).
- Thermocouple placed cell side opposite hot plate.
- Thin foam pad and Lexan plate placed between cell top and 25-lb weight.
- Thin particulate bag encapsulates cell and its top TC (not shown for clarity).



Graphic is not to scale  
and for illustration only

# Improving Interface Contact Resistance

Photo Credit: Bobby To, NREL



↕ Al layer of ISC device

← Carbon/PVDF

↕ Cathode layer

↕ Al

↕ Cathode layer

- Cathode active material contact resistance with the pure Al foil pad of our ISC is on the order of  $\sim 1 \Omega$  and is driving the resistance of the anode-to-cathode short.

- A metallic contaminant pressed into the cathode material during manufacturing would have much better contact resistance, as field failures have demonstrated

- Looking at advanced materials for improving contact resistances

- Carbon/polyvinylidene fluoride (PVDF) deposited on Al (pictured)
- High-conductivity micro-carbon fibers (pictured)

- Bonding Al disc onto the cathode active material during electrode coating.

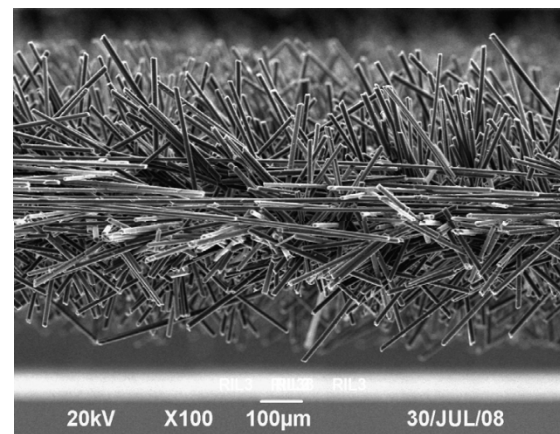


Photo courtesy of ESLI